Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/402,144	HANCK ET AL.
Examiner	Art Unit
Jung W. Kim	2132

SEARCHED			
Class	Subclass	Date	Examiner
713	161,170, 181	4/27/2006	JK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			<u> </u>

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated east search (uspgpub uspat epo jpo derwent ibmtdb)	4/27/2006	JK
updated inventor name search on palm; no double patenting issues	4/27/2006	JK
see enclosed search history		